

July 2011

FDMS8888

N-Channel PowerTrench MOSFET 30 V, 21 A, 9.5 m Ω

Features

- Max $r_{DS(on)}$ = 9.5 m Ω at V_{GS} = 10 V, I_D = 13.5 A
- Max $r_{DS(on)}$ = 14.5 m Ω at V_{GS} = 4.5 V, I_D = 10.9 A
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- MSL1 robust package design
- RoHS Compliant

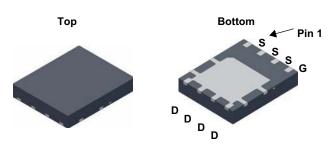


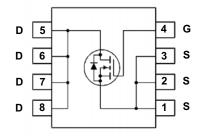
General Description

The FDMS8888 has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance.

Applications

- Synchronous Buck for Notebook Vcore and Server
- Notebook Battery Pack
- Load Switch





Power 56

MOSFET Maximum Ratings TA = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			30	V
V_{GS}	Gate to Source Voltage			±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		21	
	-Continuous (Silicon limited)	T _C = 25 °C		51	\neg
I _D	-Continuous	T _A = 25 °C	(Note 1a)	13.5	- A
	-Pulsed			80	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	54	mJ
	Power Dissipation	T _C = 25 °C		42	
P _D	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	- W
T _J , T _{STG}	Operating and Storage Junction Temperature R	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.3	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8888	FDMS8888	Power 56	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	30			V
$\frac{\Delta BV_{DS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		19		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.2	1.9	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		-7		mV/°C
		V _{GS} = 10 V, I _D = 13.5 A		8	9.5	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 10.9 \text{ A}$		11	14.5	mΩ
, ,		V _{GS} = 10 V, I _D = 13.5 A, T _J = 125 °C		12	14.5	
9 _{FS}	Forward Transconductance	V _{DD} = 10 V, I _D = 13.5 A		78		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V -45 V V -0 V	1195	1585	pF
C _{oss}	Output Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, — f = 1 MHz	234	315	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 101112	161	245	pF
R_a	Gate Resistance		0.9	2.5	Ω

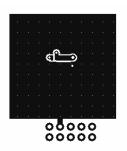
Switching Characteristics

t _{d(on)}	Turn-On Delay Time				9	18	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 13	V_{DD} = 15 V, I_{D} = 13.5 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		6	12	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = 10 V, R _{GEN} =			23	27	ns
t _f	Fall Time				4	10	ns
Q_q	Total Gate Charge	V _{GS} = 0 V to 10 V			23	33	nC
Q_q	Total Gate Charge	V _{GS} = 0 V to 5 V	V _{DD} = 15 V,		13	18	nC
Q _{gs}	Gate to Source Charge		I _D = 13.5 A		3.5		nC
Q_{gd}	Gate to Drain "Miller" Charge				5.1		nC

Drain-Source Diode Characteristics

Van Source to Drain Diede Ferward Voltag	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.1 A (Note 2)		0.74	1.2	V
VSD	V _{SD} Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 13.5 A (Note 2)		0.84	1.2	V
t _{rr}	Reverse Recovery Time	-I _F = 13.5 A, di/dt = 100 A/μs		20	32	ns
Q _{rr}	Reverse Recovery Charge			8	16	nC

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.



b. 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%. 3. Starting T $_J$ = 25 °C, L = 0.3 mH, I $_{AS}$ = 19 A, V $_{DD}$ = 27 V, V $_{GS}$ = 10 V.

Typical Characteristics $T_J = 25$ °C unless otherwise noted

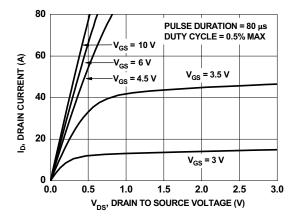


Figure 1. On Region Characteristics

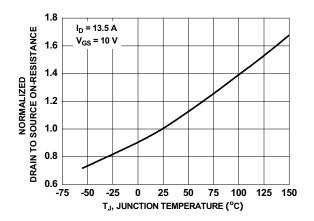


Figure 3. Normalized On Resistance vs Junction Temperature

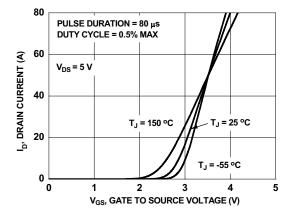


Figure 5. Transfer Characteristics

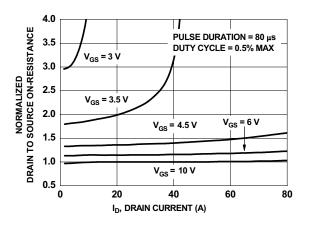


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

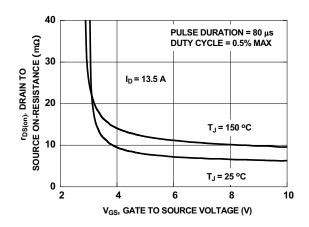


Figure 4. On-Resistance vs Gate to Source Voltage

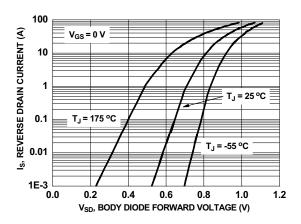


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25 °C unless otherwise noted

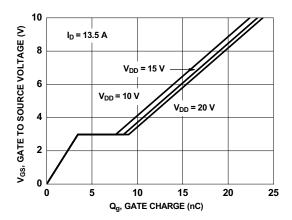


Figure 7. Gate Charge Characteristics

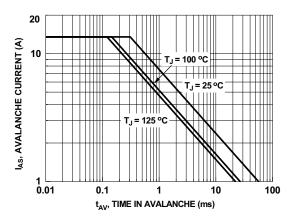


Figure 9. Unclamped Inductive Switching Capability

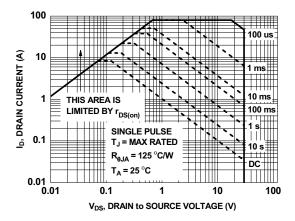


Figure 11. Forward Bias Safe Operating Area

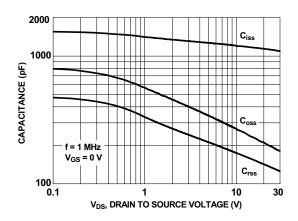


Figure 8. Capacitance vs Drain to Source Voltage

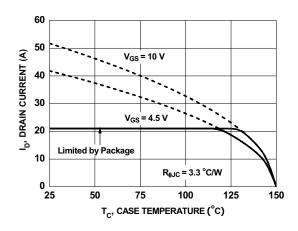


Figure 10. Maximum Continuous Drain Current vs Case Temperature

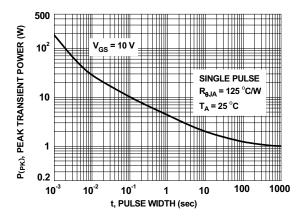


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

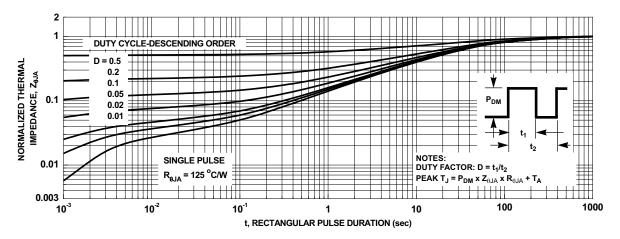
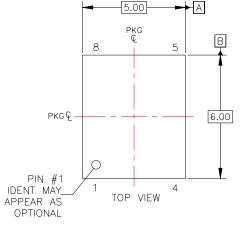
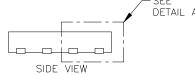
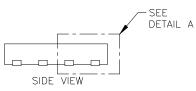


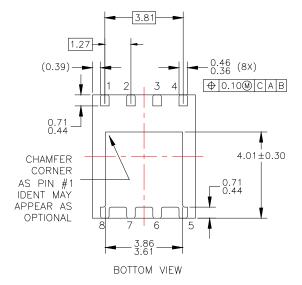
Figure 13. Junction-to-Ambient Transient Thermal Response Curve

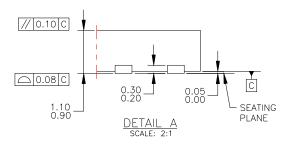
Dimensional Outline and Pad Layout

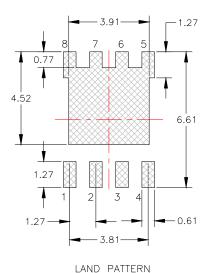




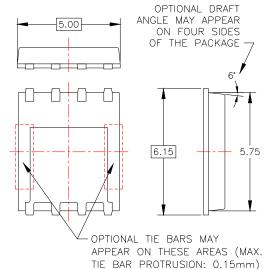








RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

- PACKAGE STANDARD REFERENCE:
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 DIMENSIONS DO NOT INCLUDE BURRS
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